Notice of References Cited

Application/Control No. 10/084,372	Applicant(s)/Patent Under Reexamination LEE, KYUNG MEE	
Examiner	Art Unit	
BRIAN P. YENKE	2614	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	Α	US-6,870,577	03-2005	Crocitti et al.	348/718
X	В	US-6,765,625	07-2004	Lee et al.	348/714
X	С	US-6,266,104	07-2001	Kim, Jin Kyeong	348/714
X	D	US-6,208,273	03-2001	Dye et al.	341/51
X	Ε	US-6,775,751	08-2004	Tremaine, Robert B.	711/154
X	F	US-6,038,033	03-2000	Bender et al.	358/1.16
X	G	US-6,879,266	04-2005	Dye et al.	341/51
X	H	US-2001/0038642	11-2001	Alvarez et al.	370/477
X	-	US-2001/0054131	12-2001	Alvarez et al.	711/105
'	7	US-			-
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0			·		
	Р					
	Q					
	R					
	s					
	Ţ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.